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Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the divisional

application:

Listing of Claims:

Claims 1-22 (cancelled):

Claim 23 (original): An implantable cardiac defibrillator circuit comprising:

a low voltage section for providing a control signal;

a high voltage section having an output for powering a load; and

a bridge section capacitively coupling the low voltage section to the high voltage section, the

bridge section adapted to operate the high voltage section in response to a signal from the low

voltage section.

Claim 24 (original): An implantable cardiac defibrillator circuit according to claim 23

wherein the bridge section further comprises a high portion adapted to operate the high voltage

section in response to a high signal from the low voltage section and a low portion adapted to

operate the high voltage section in response to a low signal from the low voltage section.

Claim 25 (original): An implantable cardiac defibrillator circuit according to claim 23

wherein the bridge section comprises an integrated circuit.

Claim 26 (original): An implantable cardiac defibrillator circuit according to claim 24

wherein the bridge section high portion and bridge section low portion comprise a first and a second

integrated circuit.

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Claim 27 (original): An implantable cardiac defibrillator circuit according to claim 23

wherein the bridge section comprises an integrated circuit and an external isolation capacitor.

Claim 28 (original): An implantable cardiac defibrillator circuit according to claim 23

wherein the low voltage section further compdses at least one isolation capacitor.

Claim 29 (original): An implantable cardiac defibrillator circuit according to claim 24

further comprising:

a first transistor having its base and emitter terminals coupled with the high voltage section

for supplying power to the load, and its gate operably coupled to the high portion of the bridge

section; and

a second transistor having its base and emitter terminals coupled with the high voltage

section for supplying power to the load, and its gate operably coupled to the low portion of the

bridge section.

Claim 30 (original): An implantable cardiac defibrillator circuit according to claim 29

wherein the bridge section high portion and low portion each further comprise:

an isolation capacitor having one terminal coupled to the low voltage portion output;

a forward-biased diode and first and second reverse-biased diodes coupled to the opposing

terminal of the isolation capacitor;

a resistor and capacitor (RC) pair coupled in parallel with the forward-biased diode and the

first reverse-biased diode; and

an NMOSFET having its gate terminal coupled with the RC and first reverse-biased diode,

and its source terminal coupled with the RC pair, forward-biased diode and gate of the first

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transistor, and its drain terminal coupled with the second reverse-biased diode and base of the first

transistor.

Claim 31 (original): The implantable cardiac defibrillator circuit of claim 23 adapted for

use with a low voltage section output within a frequency range of approximately 1 MHz-10MHz.

Claim 32 (original): The implantable cardiac defibrillator circuit of claim 23 wherein the

RC pair is selected to exhibit a time constant within a range of approximately three to ten times

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longer than the minimum frequency used for the low voltage portion output.

Claim 33 (original): The implantable cardiac defibrillator circuit of claim 23 wherein the

diodes comprise N+ substrate P- well bipolar transistors.

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